

March 1999

DS26LV31T 3V Enhanced CMOS Quad Differential Line Driver

General Description

The DS26LV31T is a high-speed quad differential CMOS driver that meets the requirements of both TIA/EIA-422-B and ITU-T V.11. The CMOS DS26LV31T features low static $I_{\rm CC}$ of 100 $\mu{\rm A}$ MAX which makes it ideal for battery powered and power conscious applications.

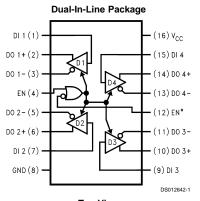
Differential outputs have the same V_{OD} guarantee ($\ge 2V$) as the 5V version.

The EN and EN* inputs allow active Low or active High control of the TRI-STATE® outputs. The enables are common to all four drivers. Protection diodes protect all the driver inputs against electrostatic discharge. Outputs have enhanced ESD protection providing greater than 7 kV tolerance. The driver and enable inputs (DI, EN, EN*) are compatible with low voltage LVTTL and LVCMOS devices.

Features

- Industrial product meets TIA/EIA-422-B (RS-422) and ITU-T V.11 recommendation
- Military product conforms to TIA/EIA-422-B (RS-422)
- Interoperable with existing 5V RS-422 networks
- Industrial and Military temperature range
- Guaranteed V_{OD} of 2V min over operating conditions
- Balanced output crossover for low EMI (typical within 40 mV of 50% voltage level)
- Low power design (330 µW 3.3V static)
- ESD ≥ 7 kV on cable I/O pins (HBM)
- Guaranteed AC parameter:
 - Maximum driver skew: 2 ns
 - Maximum transition time: 10 ns
- Pin compatible with DS26C31
- Available in SOIC and Cerpack packaging
- Standard Microcircuit Drawing (SMD) 5962-98584

Connection Diagram



Top View
Order Number DS26LV31TM or DS26LV31W
See NS Package Number M16A or W16A

Truth Table

Enables		Input	Outputs		
EN	EN*	DI	DO+	DO-	
L	Н	Х	Z	Z	
All ot	her	L	L	Н	
combinations of enable inputs		Н	Н	L	

L = Low logic state

X = Irrelevant

H = High logic state Z = TRI-STATE

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DS012642

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Driver Output Voltage

(Power Off: DO+, DO-) -0.5V to +7V

Maximum Package Power Dissipaton +25°C

M Package 1226 mW W Package 1119 mW

Derate M Package 9.8 mW/°C above +25°C Derate W Package 7.5 mW/°C above +25°C

Storage Temperature Range -65°C to $+150^{\circ}\text{C}$

Lead Temperature Range Soldering

(4 sec.) +260°C

ESD Ratings (HBM, 1.5 $k\Omega$, 100 pF)

 Driver Outputs
 ≥7 kV

 Other Pins
 ≥2.5 kV

Recommended Operating Conditions

	Min	Тур	Max	Units
Supply Voltage (V _{CC})	3.0	3.3	3.6	V
Operating Free Air Tem	perature f	Range (T	A)	
DS26LV31T	-40	+25	+85	°C
DS26LV31W	-55	+25	+125	°C
Input Rise and Fall Time			500	ns

Electrical Characteristics(Note 2) (Note 3)

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Cond	litions	Pin	Min	Тур	Max	Units
V _{OD1}	Output Differential Voltage	R _L = ∞ (No Load)		DO+,		3.3	4	V
V _{OD2}	Output Differential Voltage	$R_L = 100\Omega$ (Figure 1)		DO-	2	2.6		V
ΔV_{OD2}	Change in Magnitude of	I _O ≥ 20 mA			-400	7	400	mV
	Output Differential Voltage							
V _{OD3}	Output Differential Voltage	R _L = 3900Ω (V.11 Figure 1 (Note 7)	$R_{L} = 3900\Omega \text{ (V.11)}$ Figure 1 (Note 7)			3.2	3.6	V
V _{oc}	Common Mode Voltage	$R_L = 100\Omega$ (Figure	e 1)			1.5	2	V
ΔV_{OC}	Change in Magnitude of				-400	6	400	mV
	Common Mode Voltage	., ., .,		_				+
I_{OZ}	TRI-STATE Leakage	$V_{OUT} = V_{CC}$ or GN	ND			±0.5	±20	μA
	Current	Drivers Disabled	T	_				+
I _{sc}	Output Short Circuit Currrent	$V_{OUT} = 0V$ $V_{IN} = V_{CC}$ or	$T_A = -40^{\circ}C$ to $+85^{\circ}C$		-40	-70	-150	mA
		GND (Note 4)	$T_A = -55^{\circ}C \text{ to}$ +125°C (Note 10)		-30		-160	mA
I _{OFF}	Output Leakage Current	V _{CC} = 0V, V _{OUT} =	3V or 6V			0.03	100	μA
		$V_{CC} = 0V, V_{OUT} = -0.25V$	$T_A = -40^{\circ} \text{C to} +85^{\circ} \text{C}$			-0.08	-100	μA
			T _A = -55°C to +125°C				-200	μA
V _{IH}	High Level Input Voltage			DI,	2.0		V _{CC}	V
V _{IL}	Low Level Input Voltage			EN,	GND		0.8	V
I _{IH}	High Level Input Current	$V_{IN} = V_{CC}$		EN*			10	μA
I _{IL}	Low Level Input Current	V _{IN} = GND			-10			μA
V _{CL}	Input Clamp Voltage	$I_{IN} = -18 \text{ mA}$					-1.5	V
I _{cc}	Power Supply Current	No Load, V_{IN} (all) = V_{CC} or	$T_A = -40^{\circ}C$ to $+85^{\circ}C$	V _{CC}			100	μA
		GND	T _A = -55°C to +125°C				125	μA

Switching Characteristics - Industrial (Note 5) (Note 6)

Over supply voltage and -40°C to +85°C operating temperature range, unless otherwise specified

Sym	Parameter	Conditions	Min	Тур	Max	Units
t _{PHLD}	Differential Propagation Delay	$R_L = 100\Omega, C_L = 50 \text{ pF}$	6	10.5	16	ns
	High to Low	(Figures 2, 3)				
t _{PLHD}	Differential Propagation Delay		6	11	16	ns
	Low to High					
t _{SKD}	Differential Skew (same			0.5	2.0	ns
	channel) t _{PHLD} - t _{PLHD}					
t _{SK1}	Skew, Pin to Pin			1.0	2.0	ns
	(same device)					
t _{SK2}	Skew, Part to Part (Note 8)			3.0	5.0	ns
t _{TLH}	Differential Transition Time			4.2	10	ns
	Low to High (20% to 80%)					
t _{THL}	Differential Transition Time			4.7	10	ns
	High to Low (80% to 20%)					
t _{PHZ}	Disable Time High to Z	(Figures 4, 5)		12	20	ns
t _{PLZ}	Disable Time Low to Z			9	20	ns
t _{PZH}	Enable Time Z to High			22	32	ns
t _{PZL}	Enable Time Z to Low			22	32	ns
f _{max}	Maximum Operating		32			MHz
	Frequency (Note 9)					

Switching Characteristics - Military (Note 5) (Note 6)

Over supply voltage and -55°C to +125°C operating temperature range, unless otherwise specified

Sym	Parameter	Conditions	Min	Max	Units
t _{PHLD}	Differential Propagation Delay	$R_L = 100\Omega, C_L = 50 \text{ pF}$	5	25	ns
	High to Low	(Figures 2, 3)			
t _{PLHD}	Differential Propagation Delay		5	25	ns
	Low to High				
t _{SKD}	Differential Skew (same			5.0	ns
	channel) t _{PHLD} - t _{PLHD}				
t _{SK1}	Skew, Pin to Pin			5.0	ns
	(same device)				
t _{PHZ}	Disable Time High to Z	(Figures 4, 5)		35	ns
t _{PLZ}	Disable Time Low to Z			35	ns
t _{PZH}	Enable Time Z to High			40	ns
t _{PZL}	Enable Time Z to Low			40	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" specifies conditions of device operation.

Note 2: Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except differential voltages V_{OD1}, V_{OD2}, V_{OD3}.

Note 3: All typicals are given for V_{CC} = +3.3V, T_A = +25°C.

Note 4: Only one output shorted at a time. The output (true or complement) is configured High.

Note 5: f = 1 MHz, t_{f} and $t_{f} \leq 6$ ns, 10% to 90%.

Note 6: See TIA/EIA-422-B specifications for exact test conditions.

Note 7: This specification limit is for compliance with TIA/EIA-422-B and ITU-T V.11.

Note 8: Devices are at the same V_{CC} and within 5°C within the operating temperature range

Note 9: All channels switching, output duty cycle criteria is 40%/60% measured at 50%. This parameter is guaranteed by design and characterization.

Note 10: This parameter does not meet the TIA/EIA-422-B specification.

Parameter Measurement Information

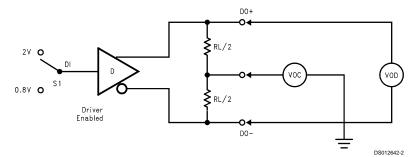


FIGURE 1. Differential Driver DC Test Circuit

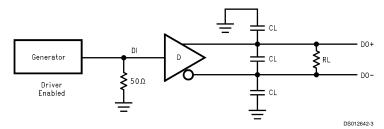


FIGURE 2. Differential Driver Propagation Delay and Transition Time Test Circuit

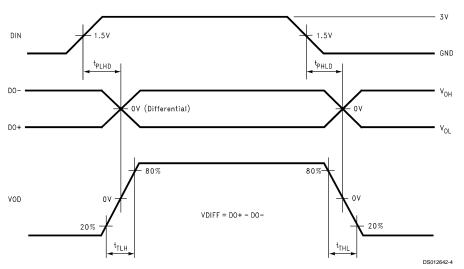
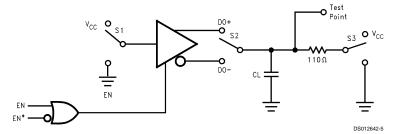


FIGURE 3. Differential Driver Propagation Delay and Transition Time Waveforms

Note 11: Generator waveform for all tests unless otherwise specified: f=1 MHz, Duty Cycle = 50% Z₀ = 50Ω , $t_f \le 10$ ns, $t_f \le 10$. Note 12: C_L includes probe and fixture capacitance.

Parameter Measurement Information (Continued)



If EN is the input, then $EN^* = High$ If EN* is the input, then EN = Low

FIGURE 4. Driver Single-Ended TRI-STATE Test Circuit

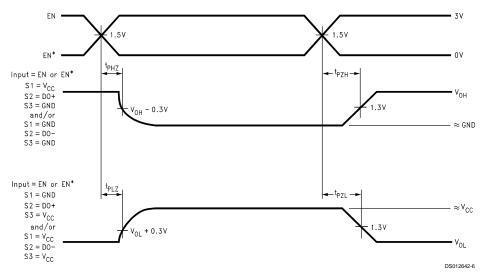


FIGURE 5. Driver Single-Ended TRI-STATE Waveforms

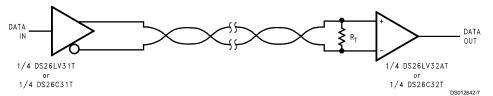
Typical Application Information

General application guidelines and hints for differential drivers and receivers may be found in the following application notes:

AN-214, AN-457, AN-805, AN-847, AN-903, AN-912, AN-916.

Power Decoupling Recommendations:

Bypass caps must be used on power pins. High frequency ceramic (surface mount is recommended) 0.1 μF in parallel with 0.01 μF at the power supply pin. A 10 μF or greater solid tantalum or electrolytic should be connected at the power entry point on the printed circuit board.



R_T is optional although highly recommended to reduce reflection.

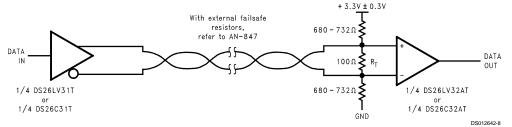
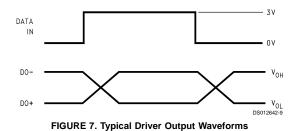
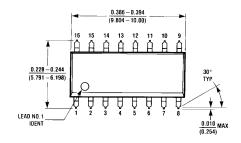
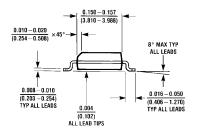


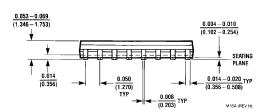
FIGURE 6. Typical Driver Connection





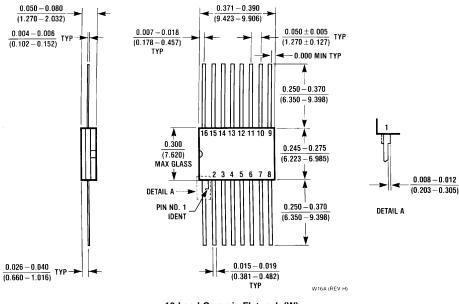






16-Lead Molded Small Outline Package (M) Order Number DS26LV31TM NS Package Number M16A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Ceramic Flatpack (W) Order Number DS26LV31W NS Package Number W16A

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